

500V N-Channel MOSFET

RCD5N50

Description

The Power MOSFET is fabricated using the advanced planar VDMOS technology.

The resulting device has low conduction resistance, superior switching performance and high avalanche energy.

V_{DSS}	500	V
I_D	5	A
$R_{DS(on),max}$	1.6	Ω
$Q_{g,typ}$	13.2	nC

Features

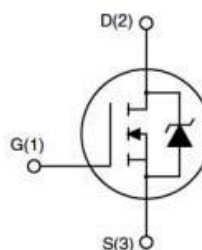
- Low $R_{DS(on)}$
- Low gate charge (typ. $Q_g = 13.2$ nC)
- 100% UIS tested
- RoHS compliant

Applications

- Power factor correction.
- Switched mode power supplies.
- LED driver.

Ordering Information

Part Number	Package	Brand
RCD5N50	TO-252	RC



TO-252

Absolute Maximum Ratings (TC=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	500	V
Continuous drain current ¹⁾ ($T_c = 25^\circ\text{C}$) ($T_c = 100^\circ\text{C}$)	I_D	5 3	A A
Pulsed drain current ²⁾	I_{DM}	20	A
Gate-Source voltage	V_{GSS}	± 30	V
Avalanche energy, single pulse ³⁾	E_{AS}	211	mJ
Power Dissipation	P_D	80	W
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$
Continuous diode forward current	I_S	5	A
Diode pulse current	$I_{S,pulse}$	50	A

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Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.57	$^{\circ}\text{C/W}$
Thermal Resistance, Junction-to-Ambient ⁴⁾	$R_{\theta JA}$	96.05	$^{\circ}\text{C/W}$
Soldering temperature, wavesoldering only allowed at leads. (1.6mm from case for 10s)	T_{sold}	260	$^{\circ}\text{C}$

Electrical Characteristics (T_J=25 $^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0 V, I _b =250 uA	500	-	-	V
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _b =250 uA	2	-	4	V
Drain cut-off current	I _{DSS}	V _{DS} =500 V, V _{GS} =0 V, T _J = 25°C T _J = 125°C	- -	-	1 100	μA
Gate leakage current, Forward	I _{GSSF}	V _{GS} =20 V, V _{DS} =0 V	-	-	100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-20 V, V _{DS} =0 V	-	-	-100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _b =2.5 A T _j = 25°C T _j = 150°C	-	 1.38 3.17	1.6	Ω
Dynamic characteristics						
Input capacitance	C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 250kHz	-	549.83	-	pF
Output capacitance	C _{oss}		-	56.73	-	
Reverse transfer capacitance	C _{rss}		-	2.93	-	
Turn-on delay time	t _{d(on)}	V _{DD} = 250V, I _b =5 A R _G = 10 Ω, V _{GS} =10 V	-	37.9	-	ns
Rise time	t _r		-	7.2	-	
Turn-off delay time	t _{d(off)}		-	18.0	-	
Fall time	t _f		-	8.1	-	
Gate charge characteristics						

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Gate to source charge	Q_{gs}	$V_{DD}=400\text{ V, } I_D=2.5A,$ $V_{GS}=0\text{ to }10\text{ V}$	-	2.6	-	nC
Gate to drain charge	Q_{gd}		-	5.8	-	
Gate charge total	Q_g		-	13.2	-	
Gate plateau voltage	$V_{plateau}$		-	4.7	-	V
Reverse diode characteristics						
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V, } I_F=5\text{ A}$	-		1.3	V
Reverse recovery time	t_{rr}	$V_R=250\text{ V, } I_F=2.5A,$ $dI_F/dt=100\text{ A}/\mu s$	-	201.4	-	ns
Reverse recovery charge	Q_{rr}		-	832.8	-	μC
Peak reverse recovery current	I_{rrm}		-	6.89	-	A

Notes:

1. Drain current limited by maximum junction temperature.
2. Repetitive Rating: Pulse width limited by maximum junction temperature.
3. $I_{AS}=6.5\text{ A, } L=10\text{ mH, } V_{DD}=60\text{ V, Starting } T_J=25\text{ }^\circ\text{C.}$
4. The value of R_{thJA} is measured by placing the device in a still air box which is one cubic foot.

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Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

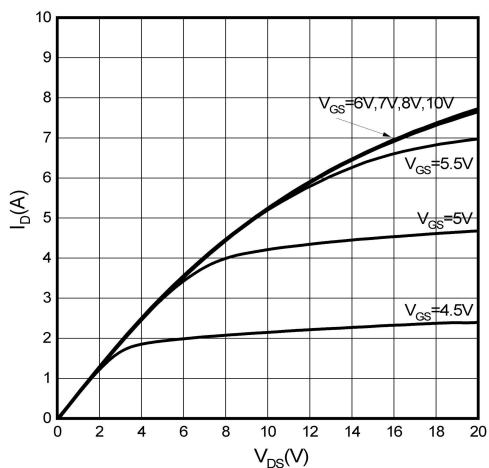


Figure 2. Transfer Characteristics

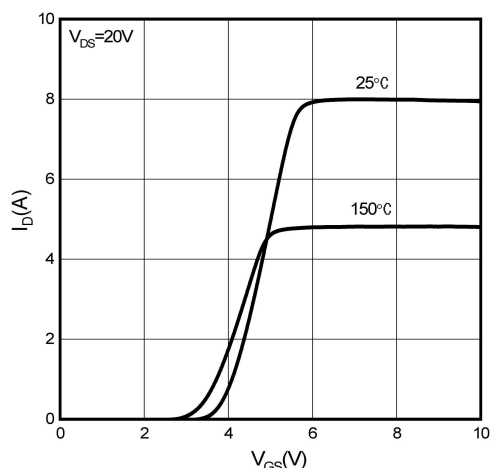


Figure 3. On-Resistance vs. Drain Current

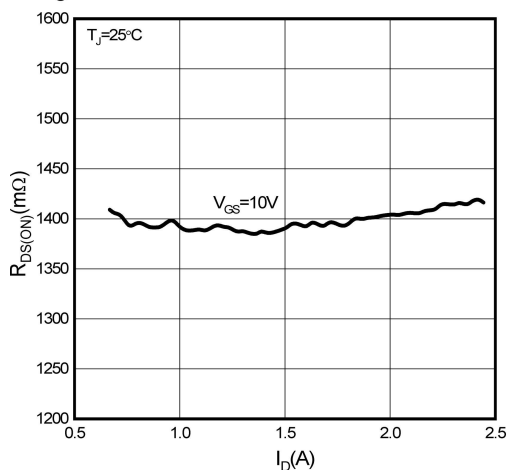


Figure 4. On-Resistance vs. Temperature

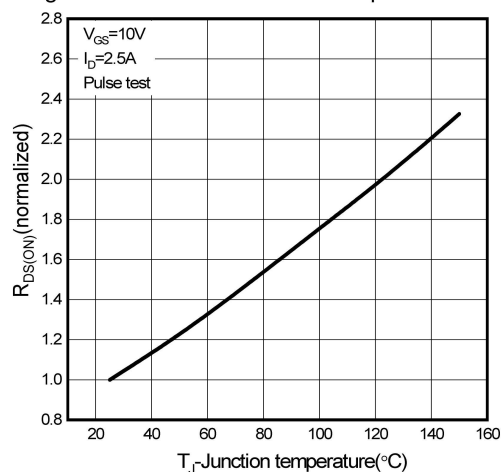


Figure 5. Breakdown Voltage vs. Temperature

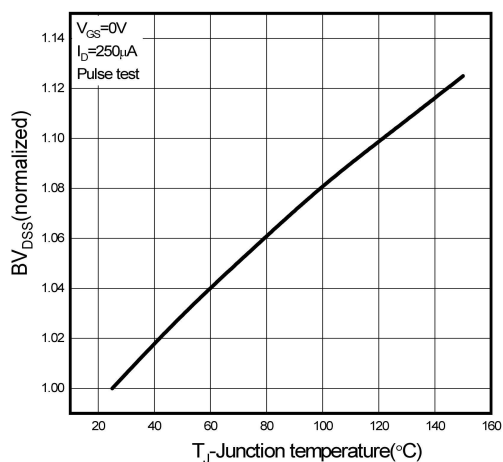
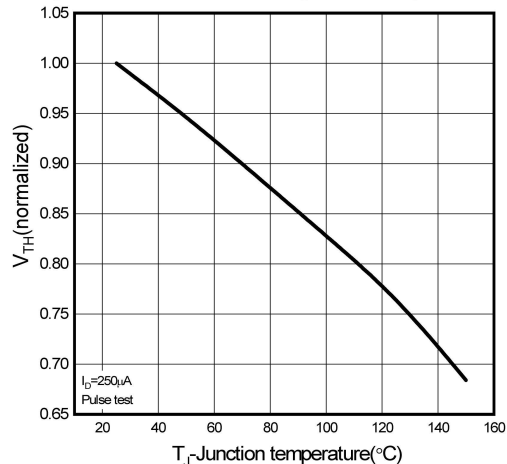


Figure 6. Threshold Voltage vs. Temperature



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Figure 7. $R_{DS(on)}$ vs. Gate Voltage

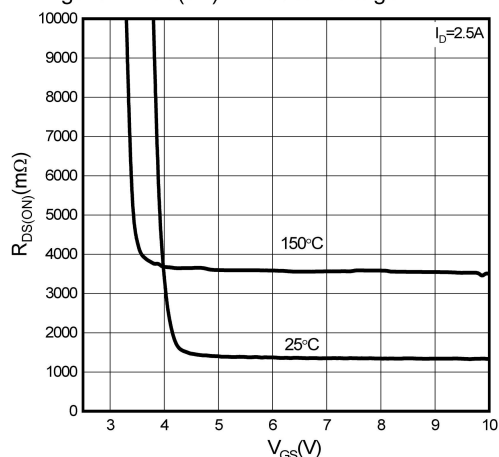


Figure 8. Body-Diode Characteristics

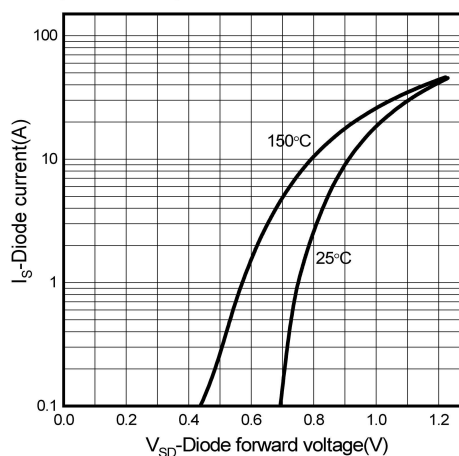


Figure 9. Capacitance Characteristics

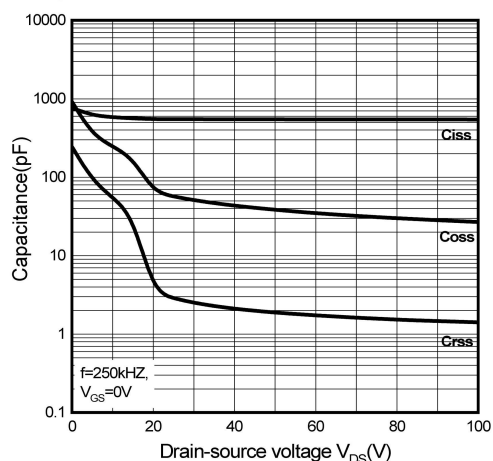


Figure 10. Gate Charge Characteristics

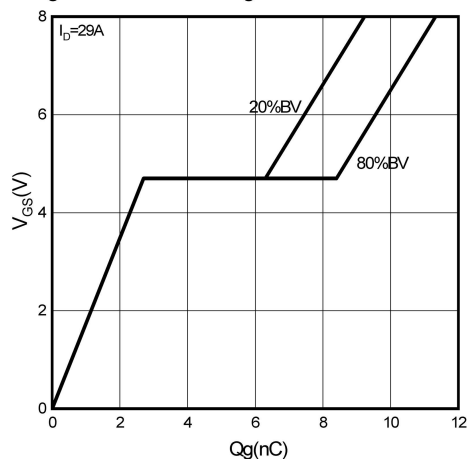


Figure 11. Drain Current Derating

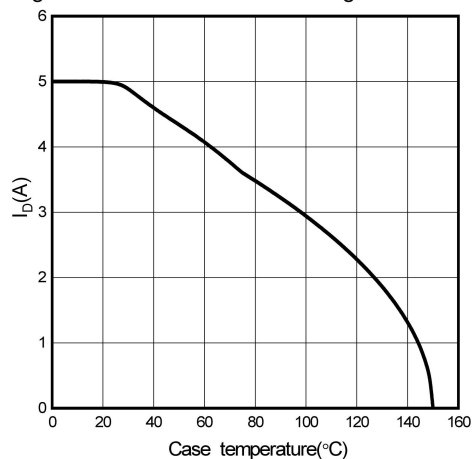
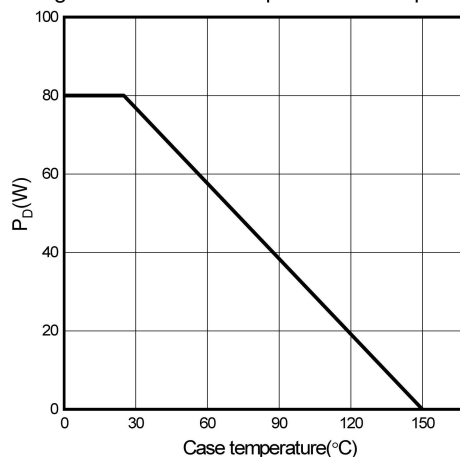


Figure 12. Power Dissipation vs. Temperature



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Figure 13. Safe Operating Area

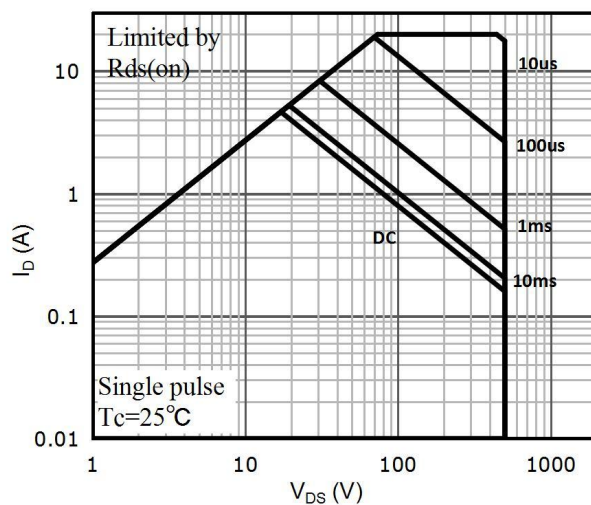
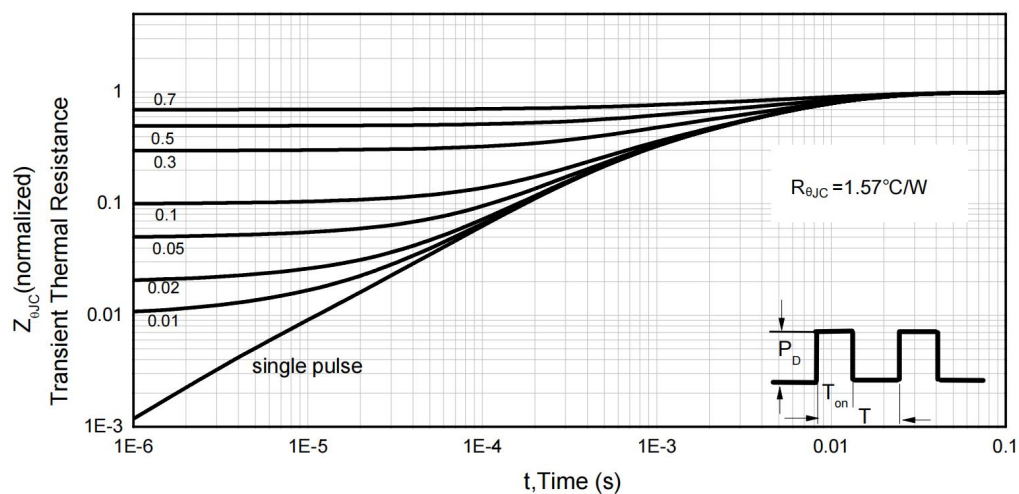
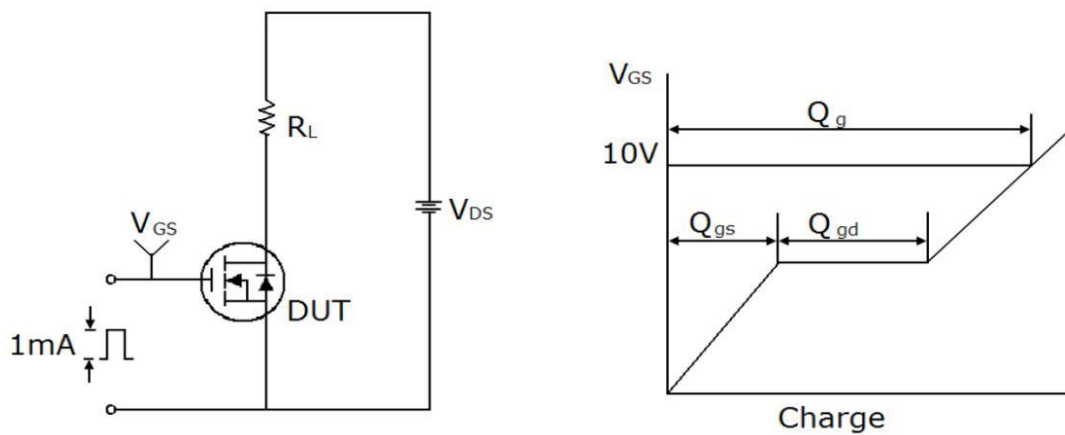


Figure 14. Normalized Maximum Transient Thermal Impedance (R_{thJC})

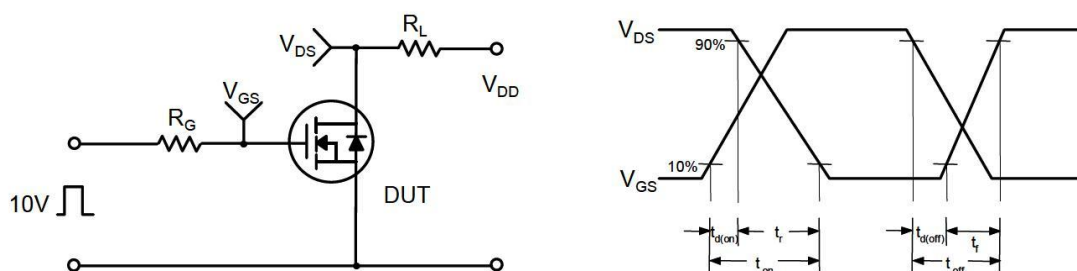


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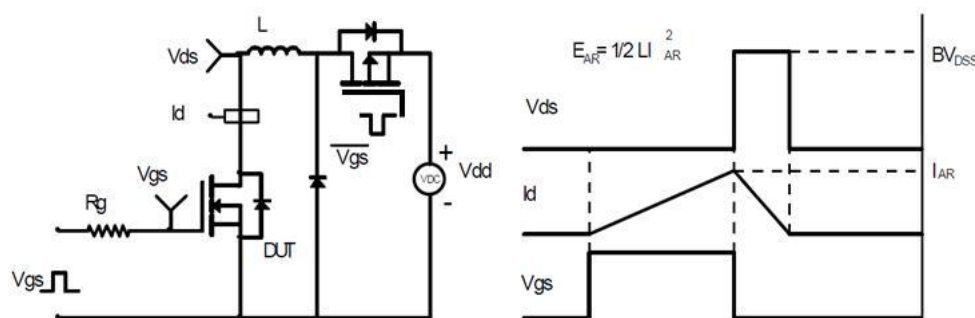
Gate Charge Test Circuit & Waveform



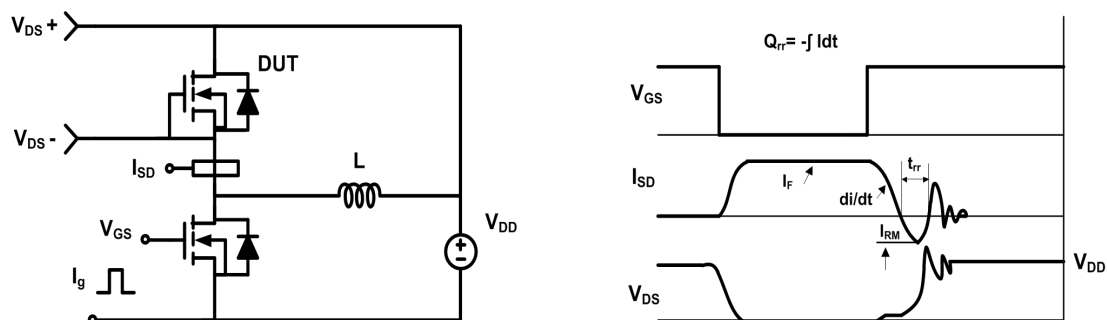
Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

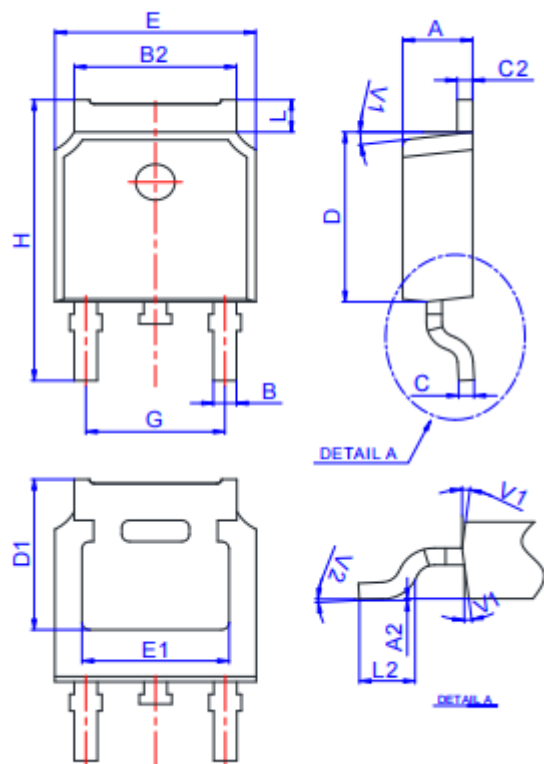


Diode Recovery Test Circuit & Waveform



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TO-252 Package outline



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°